

#### SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017 & ANSI/NCSL Z540-1-1994

#### MAGNETIC INSTRUMENTATION COMPANY LLC dba MAGNETIC INSTRUMENTATION CALIBRATION LABORATORY 8431 Castlewood Drive Indianapolis, IN 46250 Greg Umana Phone: 317 841 5524

#### CALIBRATION

Valid To: May 31, 2024

Certificate Number: 1462.01

In recognition of the successful completion of the A2LA evaluation process, accreditation is granted to this laboratory to perform the following calibrations<sup>1, 5</sup>:

I. Electrical – DC/Low Frequency

Parameter/Equipment	Range	CMC <sup>2, 3, 4</sup> (±)	Comments
DC Voltage – Measure	0.1 μV to 1 mV (1 to 10) mV (10 to 100) mV (0.1 to 1) V (1 to 10) V (10 to 100) V	$\begin{array}{c} 0.013 \ \% + 0.02 \ \mu V \\ 0.013 \ \% + 0.03 \ \mu V \\ 0.013 \ \% + 0.4 \ \mu V \\ 0.012 \ \% + 4 \ \mu V \\ 0.012 \ \% + 0.04 \ m V \\ 0.012 \ \% + 0.5 \ m V \end{array}$	Agilent 34420A DMM
	(100 to 1000) V	0.013 % + 0.01 V	Agilent 34401A DMM
DC Current – Measure	(1 to 10) mA (10 to 100) mA (0.1 to 1) A (1 to 3) A	0.13 % + 0.002 mA 0.13 % + 0.005 mA 0.12 % + 0.1 mA 0.14 % + 0.6 mA	Agilent 34401A DMM
Resistance – Measure	$\begin{array}{l} 0.1 \ \text{m}\Omega \ \text{to} \ 1 \ \Omega \\ (1 \ \text{to} \ 10) \ \Omega \\ (10 \ \text{to} \ 100) \ \Omega \\ (0.1 \ \text{to} \ 1) \ \text{k}\Omega \\ (1 \ \text{to} \ 10) \ \text{k}\Omega \\ (10 \ \text{to} \ 100) \ \text{k}\Omega \\ (0.1 \ \text{to} \ 1) \ \text{M}\Omega \\ (1 \ \text{to} \ 10) \ \text{M}\Omega \end{array}$	$\begin{array}{c} 0.014 \ \% + 0.002 \ m\Omega \\ 0.014 \ \% + 0.02 \ m\Omega \\ 0.015 \ \% + 0.2 \ m\Omega \\ 0.015 \ \% + 0.2 \ m\Omega \\ 0.014 \ \% + 0.002 \ \Omega \\ 0.014 \ \% + 0.02 \ \Omega \\ 0.014 \ \% + 0.4 \ \Omega \\ 0.015 \ \% + 4 \ \Omega \\ 0.051 \ \% + 0.1 \ k\Omega \\ 0.93 \ \% + 10 \ k\Omega \end{array}$	Agilent 34420A DMM Agilent 34401A DMM

(A2LA Cert. No. 1462.01) Revised 04/18/2024



5202 Presidents Court, Suite 220 | Frederick, MD 21703-8515 | Phone: 301 644 3248 | Fax: 240 454 9449 | www.A2LA.org

Parameter/Range	Frequency	CMC <sup>2, 3, 4</sup> (±)	Comments
AC Voltage – Measure			
(10 to 100) mV	10 Hz to 20 kHz	$0.078~\%+40~\mu\mathrm{V}$	Agilent 34401A
(0.1 to 1) V	10 Hz to 20 kHz	0.076 % + 0.3 mV	DMM
(1 to 10) V	10 Hz to 20 kHz	0.075 % + 3 mV	
(10 to 100) V	10 Hz to 20 kHz	0.075 % + 30 mV	
(100 to 750) V	10 Hz to 20 kHz	$0.081 \ \% + 230 \ mV$	
AC Current – Measure			
(0 to 1) A	10 Hz to 5 kHz	0.14 % + 0.40 mA	Agilent 34401A
(0 to 3) A	10 Hz to 5 kHz	0.24 % + 1.8 mA	DMM

### II. Magnetic Quantities

Parameter/Equipment	Range	CMC <sup>2, 3</sup> (±)	Comments
Magnetic Flux Density – Hall Probe Meter w/ Probe	(0 to 100) G (200 to 500) G (600 to 2000) G (3000 to 10 000) G (10 000 to 20 000) G (20 000 to 30 000) G (30 000 to 100 000) G	$\begin{array}{c} 0.38 \% + 0.02 \text{ G} \\ 0.36 \% + 0.1 \text{ G} \\ 0.35 \% + 0.4 \text{ G} \\ 0.35 \% + 2 \text{ G} \\ 0.35 \% + 4 \text{ G} \\ 1.2 \% + 10 \text{ G} \\ 1.2 \% + 20 \text{ G} \end{array}$	MI probe calibration station

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Parameter/Equipment	Range	CMC <sup>2, 3</sup> (±)	Comments
Magnetic Flux Density –			
MI Probe Stations	(430 to 1300) G (900 to 2600) G (1700 to 5200) G (7000 to 21 000) G	0.009 % + 0.12 G 0.044 % + 1.2 G 0.022 % + 1.2 G 0.055 % + 12 G	Metrolab PT 2025 NMR system
Reference Magnets	(0 to 100) G (100 to 500) G (500 to 2000) G (2000 to 10 000) G	0.47 % + 0.05 G 0.37 % + 0.05 G 0.38 % + 0.06 G 0.37 % + 0.94 G	MI 2100 gaussmeter
DC Magnetic Flux –			
Fluxmeters	(0 to 100) kMT (100 to 200) kMT (200 to 500) kMT (0.5 to 1) MMT (1 to 2) MMT (2 to 5) MMT (5 to 10) MMT (10 to 20) MMT (20 to 50) MMT (50 to 100) MMT	0.021 % + 0.075 kMT 0.035 % + 0.11 kMT 0.048 % + 0.1 kMT 0.049 % + 0.2 kMT 0.055 % + 0.16 kMT 0.055 % + 0.99 kMT 0.052 % + 1.3 kMT 0.054 % + 2.1 kMT 0.057 % + 2.5 kMT 0.051 % + 15 kMT	Function generator, multimeter w/shunt

Parameter/Range	Frequency	CMC <sup>2, 3</sup> (±)	Comments
AC-RM Magnetic Flux (20 to 1000) Hz – Fluxmeters	AC 1 MMT @ 20 Hz AC 500 kMT @ 40 Hz AC 200 kMT @ 80 Hz AC 100 kMT @ 160 Hz AC 100 kMT @ 320 Hz AC 100 kMT @ 1000 Hz	0.096 % + 3.2 kMT 0.11 % + 1.7 kMT 0.10 % + 0.74 kMT 0.11 % + 0.38 kMT 0.099 % + 0.2 kMT 0.11 % + 0.055 kMT	Function generator, multimeter w/shunt

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#### III. Time & Frequency

Parameter/Equipment	Range	CMC <sup>2, 3, 6</sup> (±)	Comments
Frequency – Measure	30 Hz to 10 MHz	0.01 μHz/Hz	Agilent 53210A/Locked to GPS Std

<sup>1</sup> This laboratory offers commercial calibration service.

- <sup>2</sup> Calibration and Measurement Capability Uncertainty (CMC) is the smallest uncertainty of measurement that a laboratory can achieve within its scope of accreditation when performing more or less routine calibrations of nearly ideal measurement standards or nearly ideal measuring equipment. CMCs represent expanded uncertainties expressed at approximately the 95 % level of confidence, usually using a coverage factor of k = 2. The actual measurement uncertainty of a specific calibration performed by the laboratory may be greater than the CMC due to the behavior of the customer's device and to influences from the circumstances of the specific calibration.
- <sup>3</sup> In the statement of CMC, the value is defined as the percentage of reading, unless otherwise noted.
- <sup>4</sup> The stated measured values are determined using the indicated instrument (see Comments). This capability is suitable for the calibration of the devices intended to measure or generate the measured value in the ranges indicated. CMC's are expressed as either a specific value that covers the full range or as a percent or fraction of the reading plus a fixed floor specification.
- <sup>5</sup> This scope meets A2LA's *P112 Flexible Scope Policy*.
- <sup>6</sup> The type of instrument or material being calibrated is defined by the parameter. This indicates the laboratory is capable of calibrating instruments that measure or generate the values in the ranges indicated for the listed measurement parameter.

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# **Accredited Laboratory**

A2LA has accredited

# MAGNETIC INSTRUMENTATION CALIBRATION LABORATORY

Indianapolis, IN

for technical competence in the field of

### Calibration

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017 General requirements for the competence of testing and calibration laboratories. This laboratory also meets the requirements of ANSI/NCSL Z540-1-1994 and R205 – Specific Requirements: Calibration Laboratory Accreditation Program. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).



Presented this 23<sup>rd</sup> day of May 2022.

Mr. Trace McInturff, Vice President, Accreditation Services For the Accreditation Council Certificate Number 1462.01 Valid to May 31, 2024 Revised April 18, 2024

For the calibrations to which this accreditation applies, please refer to the laboratory's Calibration Scope of Accreditation.